

Notice of References Cited	Application/Control No. 10/643,961	Applicant(s)/Patent Under Reexamination FAN ET AL.	
	Examiner Nema O. Berezny	Art Unit 2813	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0226253	12-2003	Mayer, Steve M.	29/832
	B	US-2003/0189245	10-2003	Fang, Jen Kuang	257/706
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
	O					
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NON-PATENT DOCUMENTS

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